

## 60V, 50A DUAL N CHANNEL POWER MOSFET

### GENERAL DESCRIPTION

The SFM6005DT uses advanced trench technology and design to provide excellent  $R_{DS(on)}$  with low gate charge.

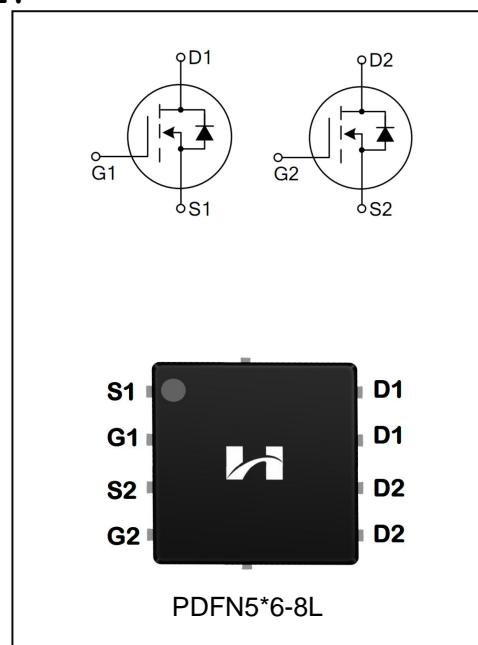
It can be used in a wide variety applications.

### Features

- ◆  $V_{DS}=60V, I_D=50A$
- ◆  $R_{DS(on)}$   
TYP:  $13.5m\Omega @ V_{GS}=10V$   
TYP:  $18.5m\Omega @ V_{GS}=4.5V$

### Applications

- ◆ Power factor correction (PFC)
- ◆ Switched mode power supplies (SMPS)
- ◆ Uninterruptible power supply (UPS)
- ◆ LED lighting power



### ORDERING INFORMATION

Part No.	Package	Marking	Material	Packing
SFM6005DT	PDFN5*6	SFM6005DT	Pb Free	Reel

**ABSOLUTE MAXIMUM RATINGS (T<sub>J</sub>=25°C unless otherwise noted)**

Characteristics	Symbol	Ratings	Unit
Drain-Source Voltage	V <sub>DS</sub>	60	V
Gate-Source Voltage	V <sub>GS</sub>	±20	V
Drain Current	I <sub>D</sub>	50	A
T <sub>C</sub> = 25°C		32	
T <sub>C</sub> = 100°C			
Drain Current Pulsed(Note 1)	I <sub>DM</sub>	180	A
Power Dissipation(T <sub>C</sub> =25°C) -Derate above 25°C	P <sub>D</sub>	65	W
		0.37	W/°C
Single Pulsed Avalanche Energy (Note 2)	E <sub>AS</sub>	270	mJ
Operation Junction Temperature Range	T <sub>J</sub>	-55~+150	°C
Storage Temperature Range	T <sub>stg</sub>	-55~+150	°C
Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	TL	300	°C

**THERMAL CHARACTERISTICS**

Characteristics	Symbol	MAX	Unit
Thermal Resistance, Junction-to-Case	R <sub>θJC</sub>	3.1	°C/W
Thermal Resistance, Junction-to-Ambient	R <sub>θJA</sub>	50	°C/W

**ELECTRICAL CHARACTERISTICS**

Characteristics	Symbol	Test conditions	Min.	Typ.	Max.	Unit
<b>Off Characteristics</b>						
Drain -Source Breakdown Voltage	B <sub>VDSS</sub>	V <sub>GS</sub> =0V, I <sub>D</sub> =250μA	60	--	--	V
Drain-Source Leakage Current	I <sub>DSS</sub>	V <sub>DS</sub> =60V, V <sub>GS</sub> =0V	--	--	1	uA
Gate-Source Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> =20V, V <sub>DS</sub> =0V	--	--	100	nA
Gate-Source Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> =-20V, V <sub>DS</sub> =0V	--	--	-100	
<b>On Characteristics</b>						
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> =250μA	1.4	1.9	2.5	V
Static Drain- Source On State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =20A	--	13.5	20	mΩ
		V <sub>GS</sub> =4.5V, I <sub>D</sub> =10A	--	18.5	29	
<b>Dynamic Characteristics</b>						
Gate Resistance	R <sub>g</sub>	V <sub>GS</sub> =0V; f=1.0MHZ	1	5	10	Ω
Input Capacitance	C <sub>iss</sub>	V <sub>DS</sub> =25V	--	1830	--	pF
Output Capacitance	C <sub>oss</sub>		--	115	--	
Reverse Transfer Capacitance	C <sub>rss</sub>		f=1.0MHZ	--	105	
<b>Switching Characteristics</b>						
Turn-on Delay Time	t <sub>d(on)</sub>	V <sub>DD</sub> =30V, V <sub>GS</sub> =10V R <sub>GS</sub> =3.3Ω, I <sub>D</sub> =20A (Note 3.4)	--	16.2	--	ns
Turn-on Rise Time	t <sub>r</sub>		--	69.8	--	
Turn-off Delay Time	t <sub>d(off)</sub>		--	173.5	--	
Turn-off Fall Time	t <sub>f</sub>		--	75.3	--	

Total Gate Charge	$Q_g$	$V_{DS}=48V, I_D=20A$ $V_{GS}=10V$ (Note 3.4)	--	46	--	nc
Gate-Source Charge	$Q_{gs}$		--	9.5	--	
Gate-Drain Charge	$Q_{gd}$		--	10.2	--	

## SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS

Characteristics	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Continuous Source Current	$I_s$	Integral Reverse P-N Junction Diode in the MOSFET	--	--	60	A
Pulsed Source Current	$I_{SM}$		--	--	180	
Diode Forward Voltage	$V_{SD}$	$I_s=20A, V_{GS}=0V$	--	0.85	1.2	V
Reverse Recovery Time	$T_{rr}$	$I_F=20A, V_R=15V,$ $dI/dt=100A/\mu s$	--	69	--	ns
Reverse Recovery Charge	$Q_{rr}$		--	26	--	nC

1. Pulse width limited by maximum junction temperature

2. L=5mH,  $V_{DD}=50V$ ,  $V_G=10V$ ,  $R_G=25\Omega$ , starting  $T_J=25^\circ C$ 3. Pulse Test: Pulse width  $\leq 300\mu s$ , Duty cycle  $\leq 2\%$ 

4. Essentially independent of operating temperature

## Typical Performance Characteristics

Figure 1. Output Characteristics

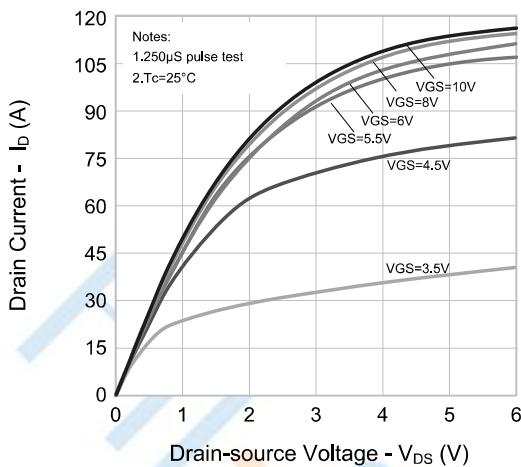


Figure 2. Transfer Characteristics

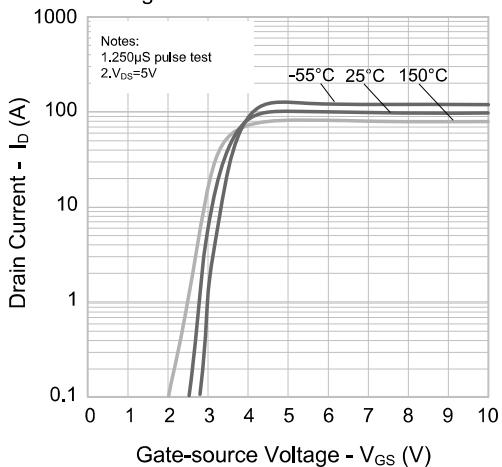


Figure 3. On-resistance vs. Drain Current

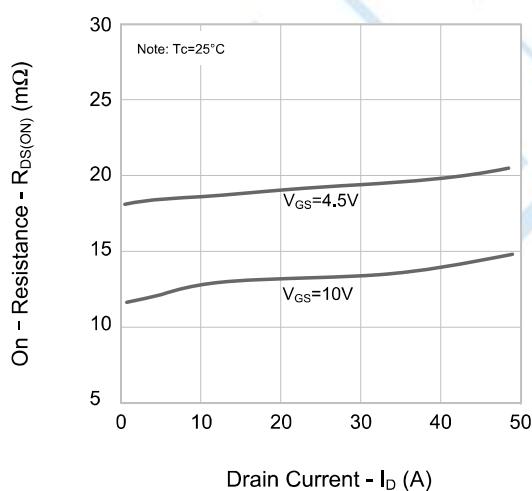


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

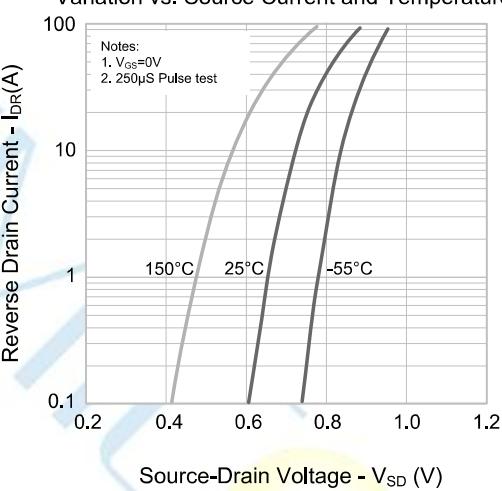


Figure 5. Capacitance Characteristics

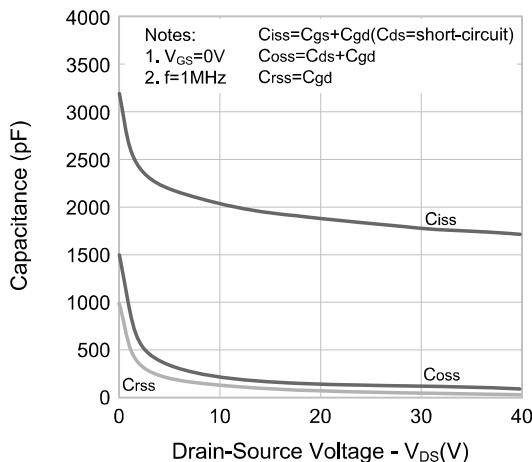
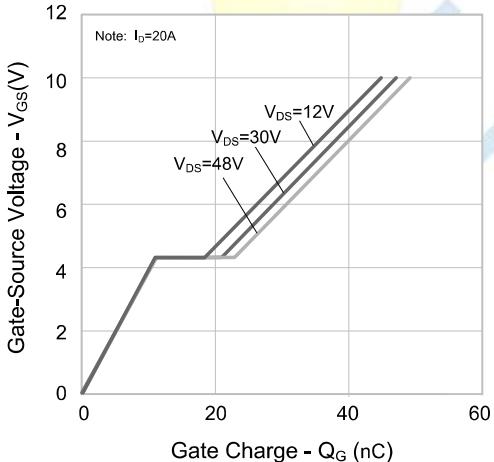
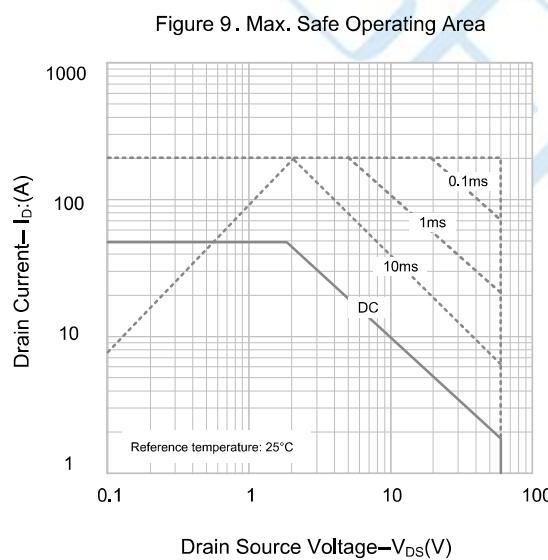
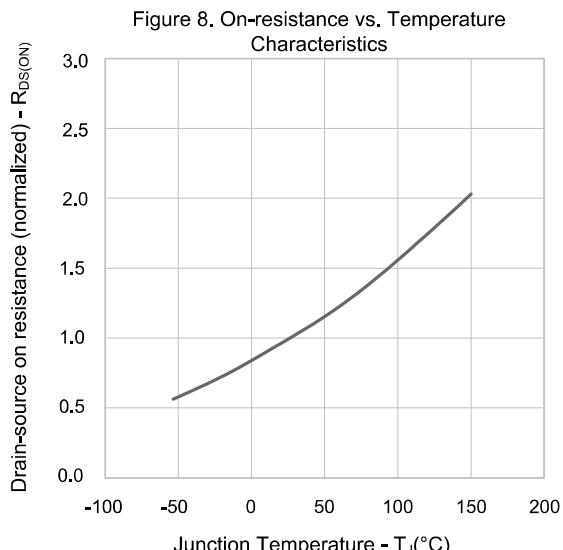
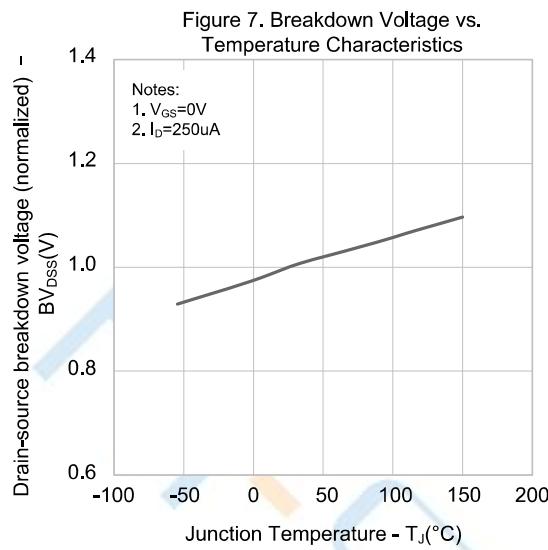


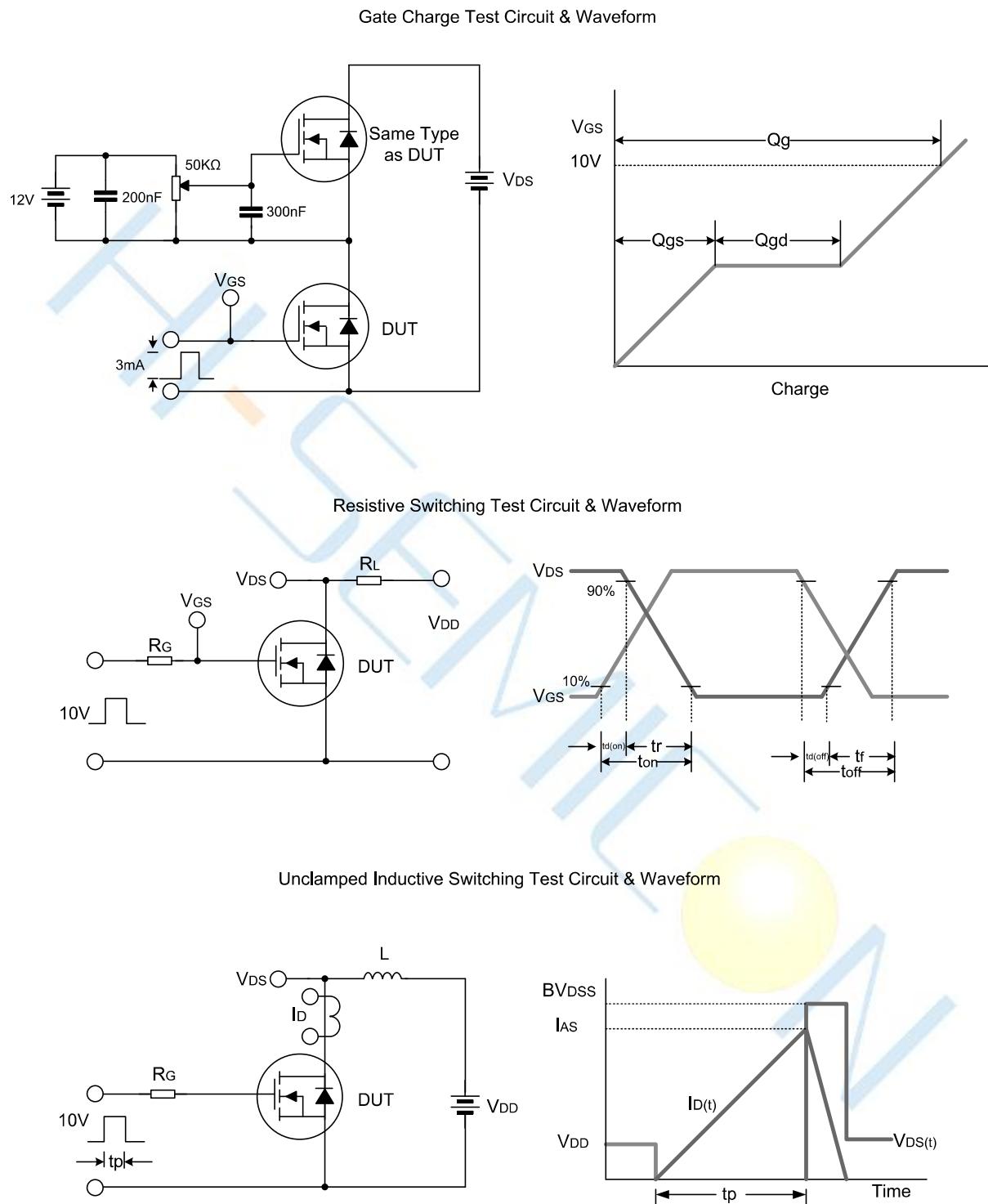
Figure 6. Gate Charge



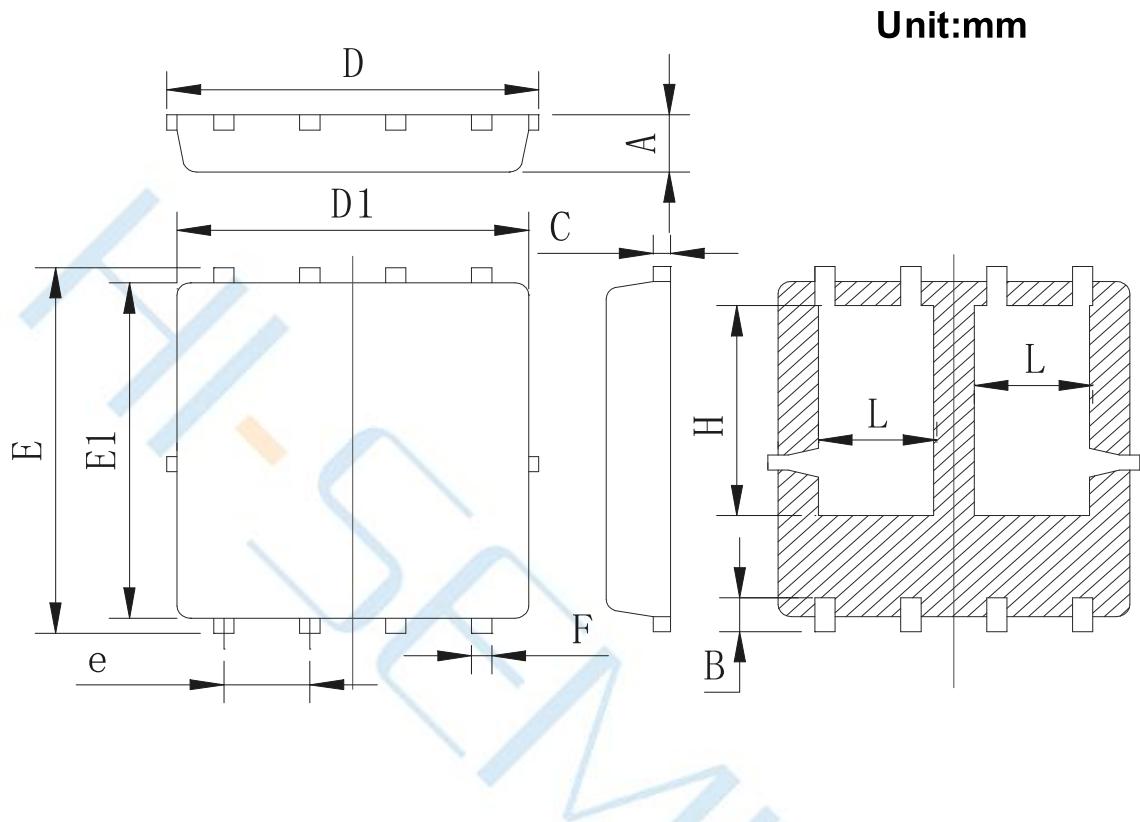
## Typical Performance Characteristics



## Test Circuit



## Package Dimensions of PDFN5\*6-8L



Symbol	Min	Typ	Max
A	0.90	0.95	1.00
B	0.48	0.58	0.68
C	0.234	0.254	0.282
D	5.40	5.50	5.60
D1	5.10	5.20	5.30
E	5.95	6.05	6.15
E1	5.45	5.55	5.65
e	1.22	1.27	1.32
F	0.25	0.30	0.35
H	3.37	3.47	3.57
L	1.60	1.70	1.80

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